Notice of References Cited Application/Control No. 10/091,573 Examiner Tan Dean D. Nguyen Applicant(s)/Patent Under Reexamination KRAENZEL ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0014457	01-2004	Stevens, Lawrence A.	455/414.1
*	В	US-2003/0101214	05-2003	Kumhyr et al.	709/203
*	С	US-2002/0023033	02-2002	Campbell et al.	705/36
*	D	US-2003/0087652	05-2003	Simon et al.	455/466
*	Е	US-6,681,247	01-2004	Payton, David W.	709/217
*	F	US-5,960,173	09-1999	Tang et al.	709/201
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	>					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.